Search Notes



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Applicant(s)/Patent Under

Examiner

Art Unit

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SEARCHED

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Class	Subclass	Date	Examiner
701	11	2/20/2008	S.K.
701	13	2/20/2008	S.K.
701	120	2/26/2008	S.K.

SEARCH NOTES

Search Notes	Date	Examiner
Consult with Thu Nguyen	2/20/2008	S.K.
EAST - Inventor	2/20/2008	S.K.
EAST - Forward & Backward	2/20/2008	S.K.
EAST - Class + Text	2/20/2008	S.K.
EAST - Text	2/25/2008	S.K.
EAST - Text	2/26/2008	S.K.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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